



Clarion Hotel Royal Christiania, Oslo, Norway November 24th - 25th, 2015

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Test Forum 2015 Local Organizer

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Call for Papers / Presentations

The 2-day TestForum 2015, the 16th event in the series, is the major event for Test professionals in the Nordic area and the Baltic states. Every year the TestForum is attended by key people from the industry's test community as well as by international vendors of test and measurement equipment and solutions.

This year the event will take place in Clarion Hotel Royal Christiania, which is located in the center of Oslo.

Nordic Test Forum hereby cordially invites you to participate and submit your contribution to TestForum 2015, which includes (but is not limited to) the following topics:

- Functional Test
- Boundary Scan
- Embedded Instruments
- RF Testing
- AOI/AXI/SPI
- ICT / Flying Probe
- Test economics
- Power Test
- Fixturing/Interfaces
- Submissions

- Future technology trends and test challenges
 Best practices in
 - Best practices in manufacturing test
- ASIC: BIST / Mixed-signal / IDDQ / IDDT
- Board test SW, BIST, diagnostics
- Quality methods and tools
- Preventive test / Prognostics
 Design to Test transfer
- Design to Test transfer / Design for Test ESD
- Test efficiency and optimization
- Data acquisition / collection / analysis
- TestForum seeks full papers and/or presentations in the area of test of electronics, including *R&D*, *Application Contributions, Best Practices, Emerging Ideas*, etc. You are welcome to submit contributions also outside the above topics as long as they stay within the field of electronics test. Focus shall be on new and upcoming challenges, opportunities, techniques and best practices in electronics test technology rather than on particular products.

Proceedings

The accepted contributions of authors that wish to provide the corresponding materials will be delivered in electronic format at the Nordic Test Forum event.

The Format of the Event

- The event format will be a two-day workshop and a small exhibition attached to it.
- November 23rd in the evening there is the AGM of the NTF.
- The mix of presentations will decide the number of sessions.
- The presentations will be 30 minutes each: 25 minutes of speech and 5 minutes for questions and comments.
- In the exhibition, attendees will have a chance to see the latest equipment and talk to exhibitors.

Key Dates

- Abstract submission:
- Notification of acceptance:
 - Conference registration
 - Presentation slides:

Further Information and Submissions

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Visit the NTF web pages at: http://www.nordictestforum.org

